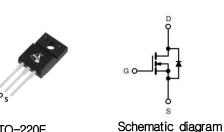
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#### **N-channel Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V) at T <sub>J</sub> max.	650			
R <sub>DS(on)</sub> max. at 25°C (mΩ)	V <sub>GS</sub> =10V	400		
Q <sub>g</sub> max. (nC)	3	0		
Q <sub>gs</sub> (nC)	5.	.7		
Q <sub>gd</sub> (nC)	8	3		
Configuration	sin	gle		



#### **Features**

- New Technology For High Voltage Device
- ID=10A(Vgs=10V)
- Ultra Low Gate Charge
- Improved dv/dt Capability
- RoHS Compliant

### **Applications**

- Switching Mode Power Supplies (SMPS)
- Power factor correction ( PFC )
- Uninterruptible Power Supply ( UPS )

ORDERING INFORMATION				
Device	SPC60R400G			
Device Package	TO-220F			
Marking	60R400G			

ABSOLUTE MAXIMUM RATINGS (Tc = 25°C, unless otherwise noted)					
Parameter	Symbol	Limit	Unit		
Drain to Source Voltage	V <sub>DSS</sub>	600	V		
Continuous Drain Current (@T <sub>C</sub> =25°C)		10 (1)	Α		
Continuous Drain Current (@T <sub>C</sub> =100°C)	l <sub>D</sub>	6.4 (1)	Α		
Drain current pulsed (2)	I <sub>DM</sub>	30 (1)	Α		
Gate to Source Voltage	$V_{GS}$	±30	V		
Single pulsed Avalanche Energy (3)	E <sub>AS</sub>	280	mJ		
MOSFET dv/dt ruggedness (@V <sub>DS</sub> =0~400V)	dv/dt	25	V/ns		
Peak diode Recovery dv/dt (4)	dv/dt	15	V/ns		
Total power dissipation (@T <sub>C</sub> =25°C)	J	32.7	W		
Derating Factor above 25°C	$P_{D}$	0.26	W/ºC		
Operating Junction Temperature & Storage Temperature	T <sub>STG</sub> , T <sub>J</sub>	-55 to + 150	°C		
Maximum lead temperature for soldering purpose	T∟	260	°C		
Mounting torque (5)		0.4~0.6	N.m		

#### Notes

- 1. Drain current is limited by maximum junction temperature.
- 2. Repetitive rating : pulse width limited by junction temperature.
- 3 L = 140mH,  $I_{AS} = 2A$ ,  $V_{DD} = 50V$ ,  $R_G = 25\Omega$ , Starting at  $T_J = 25^{\circ}C$
- 4.  $I_{SD} \le I_D$ , di/dt = 100A/us,  $V_{DD} \le 480V$ , Starting at  $T_J = 25$ °C
- 5. Mounting consideration for TO220 Fullpack:

  M3 screw plus flat washer is suggested, free

M3 screw plus flat washer is suggested, free of burr between devices and contact area, the devices are to be mounted to a hole not larger than 3.6mm in contact diameter (chamfer included).



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THERMAL CHARACTERISTICS						
Parameter	Symbol	Value	Unit			
Thermal resistance, Junction to case	R <sub>thjc</sub>	3.82	°C/W			
Thermal resistance, Junction to ambient	R <sub>thja</sub>	80	°C/W			

ELECTRICAL CHARACTERISTICS (T <sub>C</sub> = 25°C unless otherwise specified)						
Parameter	Symbol	Test conditions	Min.	Тур.	Max.	Unit
Off Characteristics						
Drain to source breakdown voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	600			V
Breakdown voltage temperature coefficient	ΔBV <sub>DSS</sub> / ΔTJ	I <sub>D</sub> =250uA, referenced to 25°C		0.7		V/°C
Drain to source leakage current	_	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V			1	uA
	I <sub>DSS</sub>	V <sub>DS</sub> =600V, T <sub>C</sub> =125°C			10	uA
Gate to source leakage current, forward	I <sub>GSS</sub>	V <sub>GS</sub> =30V, V <sub>DS</sub> =0V			100	nA
Gate to source leakage current, reverse	IGSS	V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V			-100	nA
On Characteristics						
Gate threshold voltage	$V_{GS(TH)}$	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	2.5	3	3.5	V
Drain to source on state resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =5A		340	400	mΩ
Forward Transconductance	Gfs	$V_{DS} = 20 \text{ V}, I_{D} = 5 \text{A}$		8		S
Dynamic Characteristics						
Input capacitance	C <sub>iss</sub>			1030		
Output capacitance	Coss	V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, f=1MHz		87		pF
Reverse transfer capacitance	C <sub>rss</sub>	1		4.5		
Turn on delay time	t <sub>d(on)</sub>			9		
Rising time	tr	$V_{DS}$ =350V, $I_{D}$ =10A , $R_{G}$ =18 $\Omega$ , $V_{GS}$ =10V		4		
Turn off delay time	t <sub>d(off)</sub>			50		ns
Fall time	t <sub>f</sub>			5		
Total gate charge	$Q_g$	V <sub>DS</sub> =420V, V <sub>GS</sub> =10V, I <sub>D</sub> =10A		23	30	
Gate-source charge	Q <sub>gs</sub>			5.7		nC
Gate-drain charge	$Q_{gd}$			8		

SOURCE TO DRAIN DIODE RATINGS CHARACTERISTICS							
Parameter	Symbol	Test conditions	Min.	Тур.	Max.	Unit	
Continuous source current	Is	Integral reverse p-n Junction _ diode in the MOSFET			10	Α	
Pulsed source current	I <sub>SM</sub>				30	Α	
Diode forward voltage drop.	V <sub>SD</sub>	I <sub>S</sub> =10A, V <sub>GS</sub> =0V		0.9	1.3	<b>V</b>	
Reverse recovery time	T <sub>rr</sub>	I <sub>S</sub> =10A, V <sub>GS</sub> =0V, dI <sub>F</sub> /dt=100A/us		250		ns	
Reverse recovery Charge				2.5		uC	

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Fig1. Output characteristics

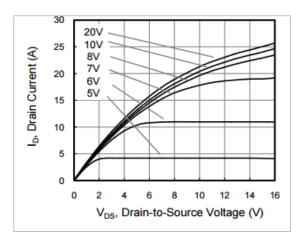


Fig3. Gate charge characteristics

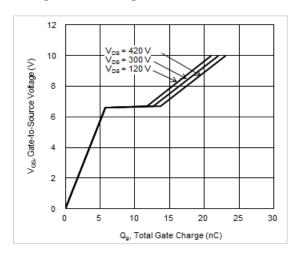


Fig 5. RDS(ON) vs junction temperature

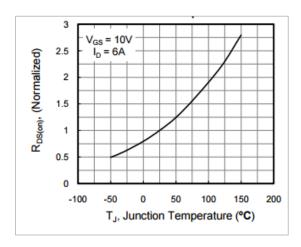


Fig2. Maximum Drain Current vs. Case Temperature

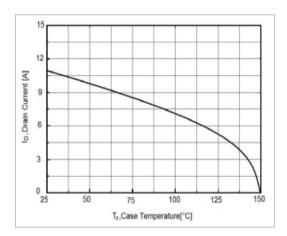


Fig 4. Capacitance Characteristics

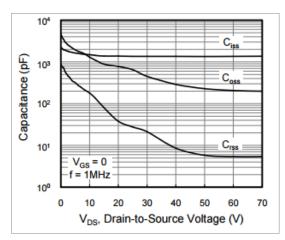
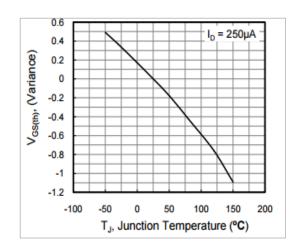


Fig 6. Threshold Voltage vs Junction Temperature



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Fig 7. Safe operating area

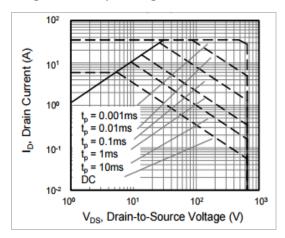


Fig 9. Forward characteristics of reverse diode

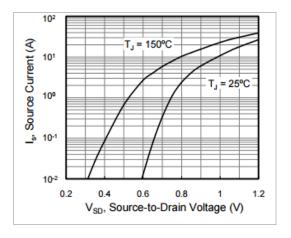


Fig 11. Gate charge test circuit & waveform

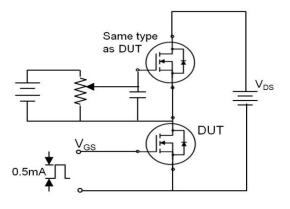


Fig 8. Transient thermal impedance

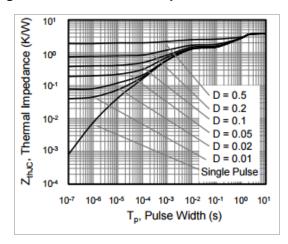
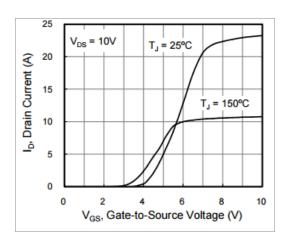
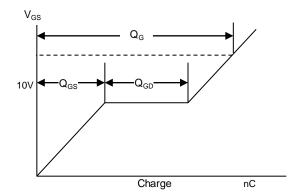


Fig 10 . Transfer characteristics





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#### Fig 12. Switching time test circuit & waveform

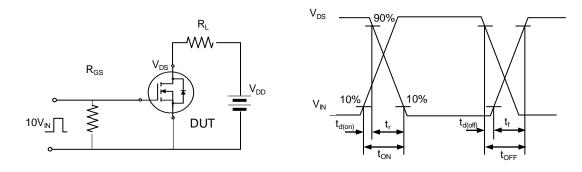


Fig 13. Unclamped Inductive switching test circuit & waveform

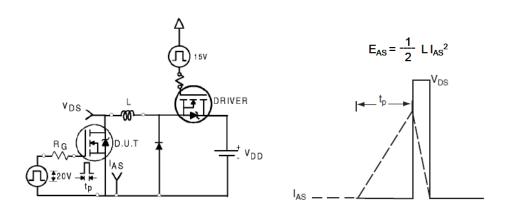
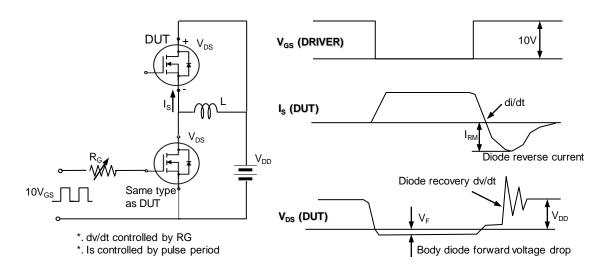


Fig 14. Peak diode recovery dv/dt test circuit & waveform



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